Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/518,124	LUER ET AL.
Examiner	Art Unit
John J. Figueroa	1712

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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(INCLUDING SEARCH	DATE	EXMR
WEST (Searched key terms in class 520's; search summary attached	6/22/2007	JJF
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